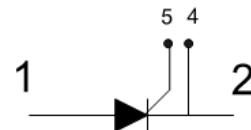

Date: 27th Aug, 2016
Data Sheet Issue: 5

Phase Control Thyristor Module Type MCO741-22io1

Absolute Maximum Ratings

V_{RRM} V_{DRM} [V]	Type
2200	MCO741-22io1



	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V_{DRM}	Repetitive peak off-state voltage ¹⁾	2200	V
V_{DSM}	Non-repetitive peak off-state voltage ¹⁾	2300	V
V_{RRM}	Repetitive peak reverse voltage ¹⁾	2200	V
V_{RSM}	Non-repetitive peak reverse voltage ¹⁾	2300	V

	OTHER RATINGS	MAXIMUM LIMITS	UNITS
$I_{T(AV)M}$	Maximum average on-state current, $T_c=83^\circ\text{C}$ ²⁾	740	A
$I_{T(AV)M}$	Maximum average on-state current, $T_c=100^\circ\text{C}$ ²⁾	500	A
$I_{T(RMS)M}$	Nominal RMS on-state current, $T_c=25^\circ\text{C}$ ²⁾	2110	A
$I_{T(d.c.)}$	D.C. on-state current, $T_c=25^\circ\text{C}$	1775	A
I_{TSM}	Peak non-repetitive surge $t_p=10\text{ms}$, $V_{rm}=60\%V_{RRM}$ ³⁾	29	kA
I_{TSM2}	Peak non-repetitive surge $t_p=10\text{ms}$, $V_{rm}\leq 10\text{V}$ ³⁾	32	kA
I^2t	I^2t capacity for fusing $t_p=10\text{ms}$, $V_{rm}=60\%V_{RRM}$ ³⁾	4.21×10^6	A^2s
I^2t	I^2t capacity for fusing $t_p=10\text{ms}$, $V_{rm}\leq 10\text{V}$ ³⁾	5.12×10^6	A^2s
$(di/dt)_{cr}$	Critical rate of rise of on-state current ⁴⁾	(continuous, 50Hz)	100
		(repetitive, 50Hz, 60s)	200
		(non-repetitive)	400
V_{RGM}	Peak reverse gate voltage	5	V
$P_{G(AV)}$	Mean forward gate power	4	W
P_{GM}	Peak forward gate power	30	W
V_{ISOL}	Isolation Voltage ⁵⁾	3000	V
$T_{vj\ op}$	Operating temperature range	-40 to +125	$^\circ\text{C}$
T_{stg}	Storage temperature range	-40 to +150	$^\circ\text{C}$

Notes:

- 1) T_{vj} -40°C to 125°C.
- 2) Single phase; 50 Hz, 180° half-sinewave.
- 3) Half-sinewave, 125°C T_{vj} initial.
- 4) $V_D = 67\% V_{DRM}$, $I_{FG} = 2 \text{ A}$, $t_r \leq 0.5\mu\text{s}$, $T_c = 125^\circ\text{C}$.
- 5) AC RMS voltage, 50 Hz, 1min test

Characteristics

	PARAMETER	MIN.	TYP.	MAX.	TEST CONDITIONS ¹⁾	UNITS
V _{TM}	Maximum peak on-state voltage	-	-	1.40 1.57	I _{TM} =2220A I _{TM} =3000A	V V
V _{T0}	Threshold voltage	-	-	0.85		V
r _T	Slope resistance	-	-	0.277		mΩ
(dv/dt) _{cr}	Critical rate of rise of off-state voltage	1000	-	-	V _D = 80% V _{DRM} , linear ramp, Gate o/c	V/μs
I _{DRM}	Peak off-state current	-	-	150	Rated V _{DRM}	mA
I _{RRM}	Peak reverse current	-	-	150	Rated V _{RRM}	
V _{GT}	Gate trigger voltage	-	-	2.5	T _{vj} = 25°C, V _D = 12 V, I _T = 3 A	V
I _{GT}	Gate trigger current	-	-	250		mA
I _H	Holding current	-	-	500	T _{vj} = 25°C	mA
I _L	Latching current	-	-	1500	T _{vj} = 25°C	mA
t _{gd}	Gate controlled turn-on delay time	-	1.0	2.5	V _D =40% V _{DRM} , I _T =765A, di/dt=10A/μs, I _{FG} =2A, t _r =0.5μs, T _j =25°C	μs
t _{gt}	Turn-on time	-	1.5	3.5		μs
t _q	Turn-off time	-	290	-	I _{TM} =765A, t _p =1000μs, di/dt=10A/μs, V _r =100V, V _{dr} =67%V _{DRM} , dV _{dr} /dt=20V/μs	μs
		-	385	-	I _{TM} =765A, t _p =1000μs, di/dt=10A/μs, V _r =100V, V _{dr} =67%V _{DRM} , dV _{dr} /dt=200V/μs	μs
R _{thJC}	Thermal resistance, junction to case	-	-	0.042		K/W
R _{thCH}	Thermal resistance, case to heatsink	-	-	0.010		K/W
F ₁	Mounting torque (to heatsink)	5.1	-	6.9		Nm
F ₂	Mounting torque (to terminals)	16.2	-	19.8		Nm
W _t	Weight	-	2.8	-		kg

Notes:

1) Unless otherwise indicated T_{vj}=125°C.

Notes on Ratings and Characteristics

1.0 Voltage Grade Table

Voltage Grade	V_{DRM} V	V_{DSM} V	V_D DC V	V_R
22	2200	2300		1350

2.0 Extension of Voltage Grades

This report is applicable to other voltage grades when supply has been agreed by Sales/Production.

3.0 Repetitive dv/dt

Standard dv/dt is 1000V/ μ s.

4.0 Snubber Components

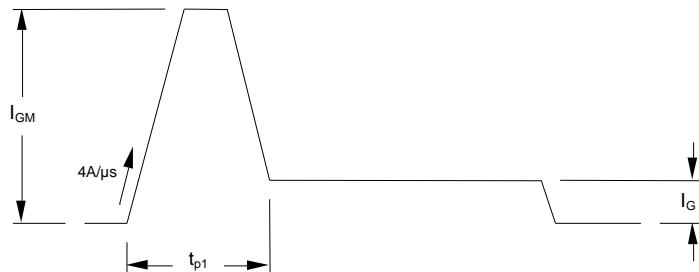
When selecting snubber components, care must be taken not to use excessively large values of snubber capacitor or excessively small values of snubber resistor. Such excessive component values may lead to device damage due to the large resultant values of snubber discharge current. If required, please consult the factory for assistance.

5.0 Rate of rise of on-state current

The maximum un-primed rate of rise of on-state current must not exceed 400A/ μ s at any time during turn-on on a non-repetitive basis. For repetitive performance, the on-state rate of rise of current must not exceed 100A/ μ s at any time during turn-on. Note that these values of rate of rise of current apply to the total device current including that from any local snubber network.

6.0 Gate Drive

The nominal requirement for a typical gate drive is illustrated below. An open circuit voltage of at least 30V is assumed. This gate drive must be applied when using the full di/dt capability of the device.



The magnitude of I_{GM} should be between five and ten times I_{GT} , which is shown on page 2. Its duration (t_{p1}) should be 20 μ s or sufficient to allow the anode current to reach ten times I_L , whichever is greater. Otherwise, an increase in pulse current could be needed to supply the necessary charge to trigger. The 'back-porch' current I_G should remain flowing for the same duration as the anode current and have a magnitude in the order of 1.5 times I_{GT} .

7.0 Computer Modelling Parameters

7.1 Thyristor dissipation calculations

$$I_{AV} = \frac{-V_{T0} + \sqrt{V_{T0}^2 + 4 \cdot ff^2 \cdot r_T \cdot W_{AV}}}{2 \cdot ff^2 \cdot r_T}$$

and:

$$W_{AV} = \frac{\Delta T}{R_{th}}$$

$$\Delta T = T_{j\max} - T_C$$

Where $V_{T0} = 0.85$ V, $r_T = 0.277$ mΩ.

R_{th} = Supplementary thermal impedance, see table below and

ff = Form factor, see table below.

Supplementary Thermal Impedance (Junction to Case)							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	0.0465	0.0460	0.0453	0.0448	0.0439	0.0428	0.0420
Sine wave	0.0460	0.0453	0.0447	0.0442	0.0428		

Form Factors							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	3.464	2.449	2	1.732	1.414	1.149	1
Sine wave	3.98	2.778	2.22	1.879	1.57		

7.2 Calculating thyristor V_T using ABCD coefficients – For loss calculations

The on-state characteristic, I_T vs. V_T , is represented in two ways;

- (i) the well established V_{T0} and r_T tangent used for rating purposes and
- (ii) a set of constants A, B, C, D, forming the coefficients of the representative equation for V_T in terms of I_T given below:

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

The constants, derived by curve fitting software, are given below for both hot and cold characteristics. The resulting values for V_T agree with the true device characteristic over a current range, which is limited to that plotted.

25°C Coefficients		125°C Coefficients	
A	0.6613111	A	0.5027666
B	0.05783103	B	0.04296551
C	1.38226×10 ⁻⁴	C	1.58061×10 ⁻⁴
D	-2.06312×10 ⁻⁴	D	4.553923×10 ⁻³

7.3 D.C. Thermal Impedance Calculation

$$r_t = \sum_{p=1}^{p=n} r_p \cdot \left(1 - e^{\frac{-t}{\tau_p}} \right)$$

Where $p = 1$ to n

- n = number of terms in the series and
 t = Duration of heating pulse in seconds.
 r_t = Thermal resistance at time t .
 r_p = Amplitude of p_{th} term.
 τ_p = Time Constant of r_{th} term.

The coefficients for this device are shown in the tables below:

D.C. Junction to Case			
Term	1	2	3
r_p	0.01904887	0.01751398	5.364393×10^{-3}
τ_p	21.99824	1.079638	0.0132514

Curves

Figure 1 – On-state characteristics of Limit device

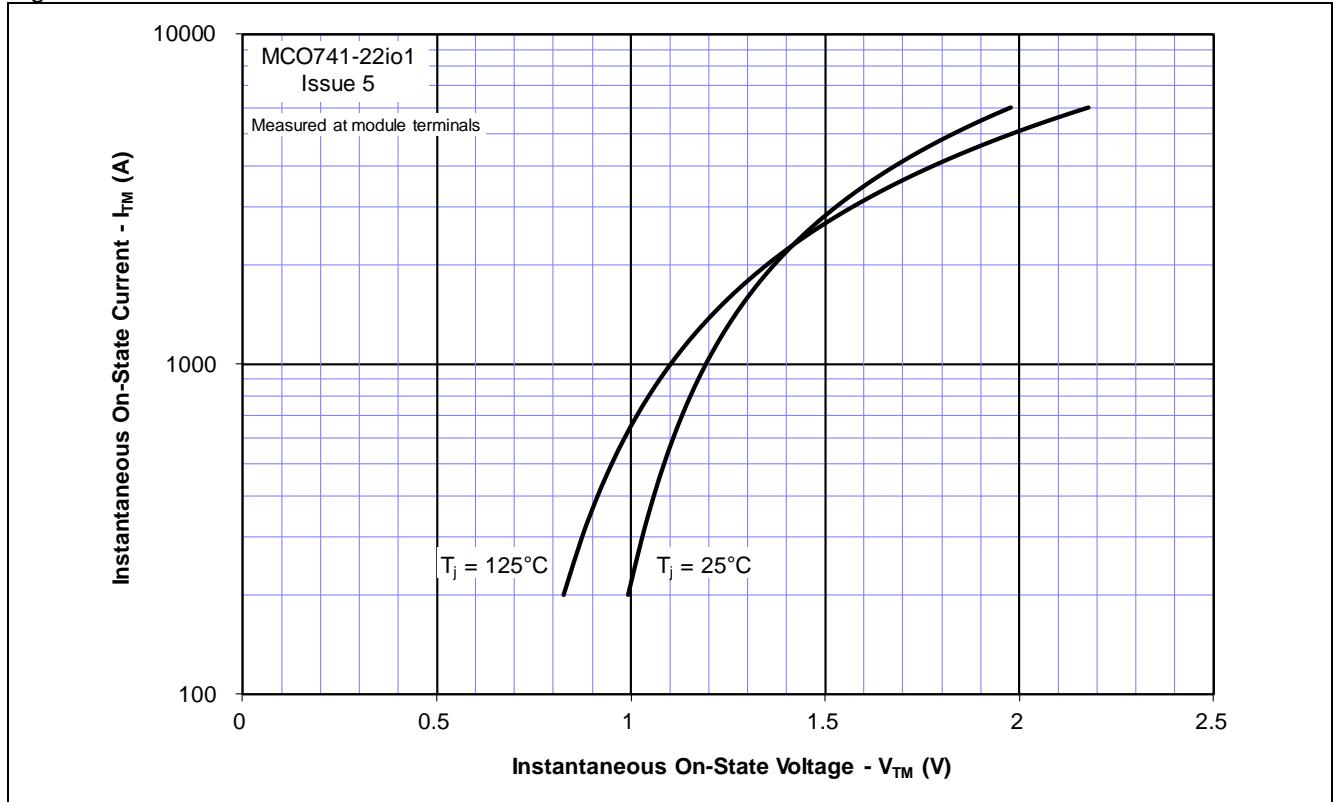


Figure 2 – Gate characteristics – Trigger limits

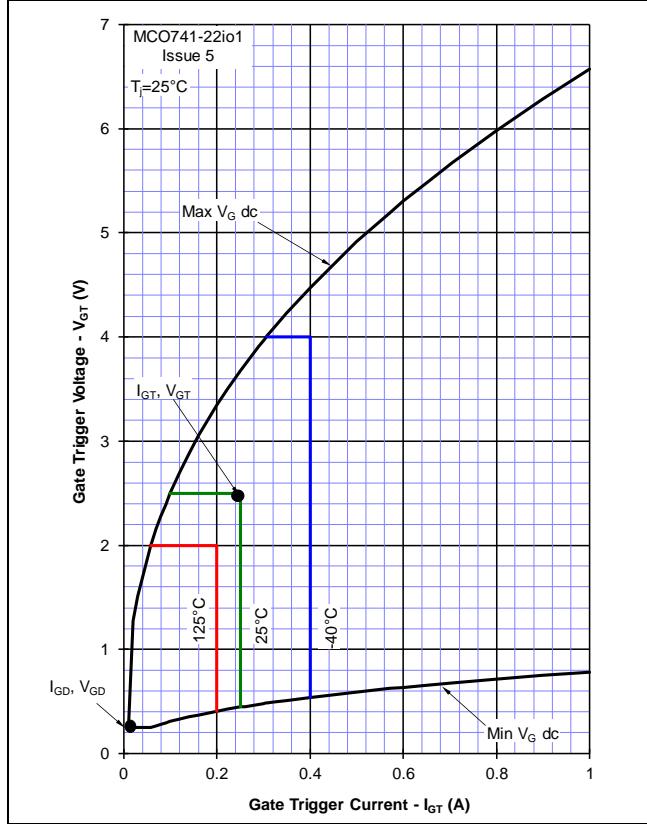


Figure 3 – Gate characteristics – Power curves

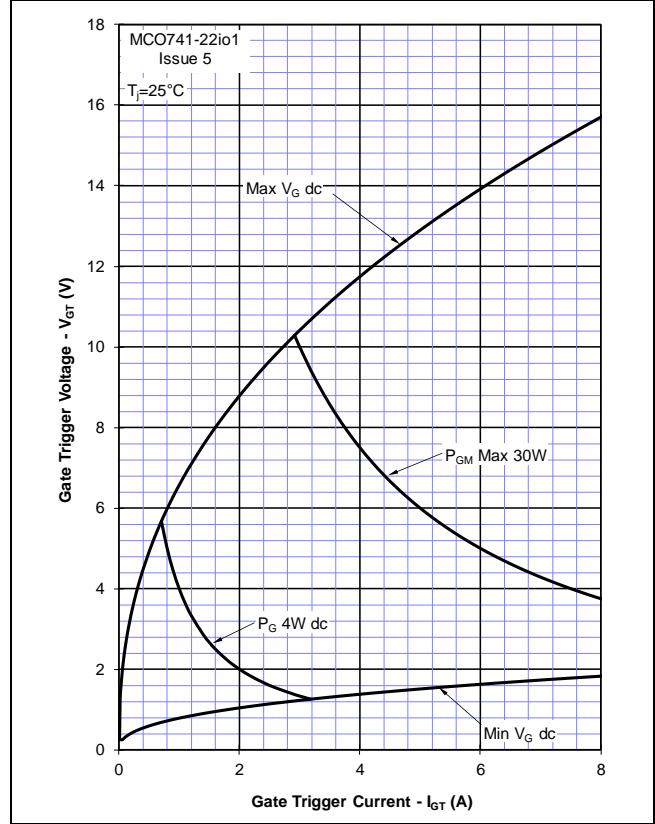


Figure 4 – On-state current vs. Power dissipation – Sine wave

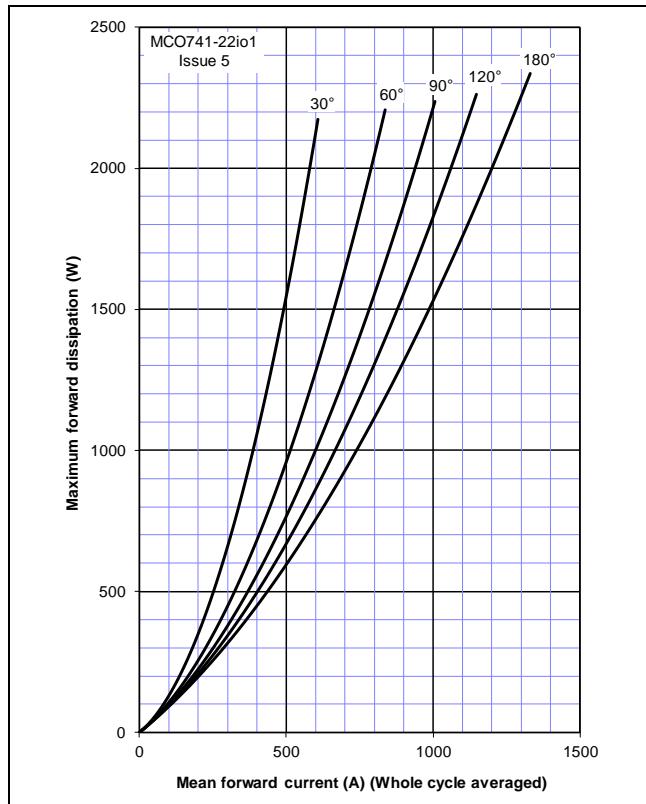


Figure 5 – On-state current vs. Heatsink temperature – Sine wave

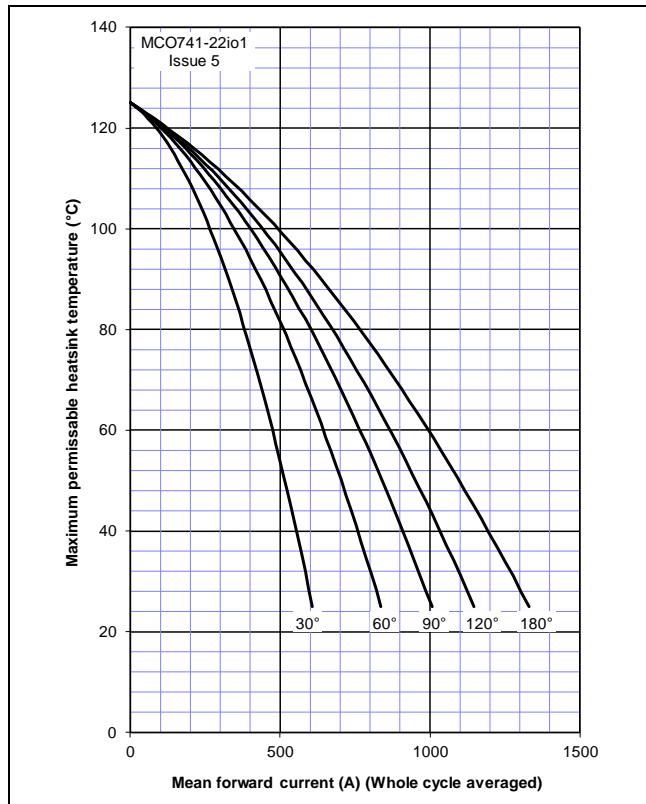


Figure 6 – On-state current vs. Power dissipation – Square wave

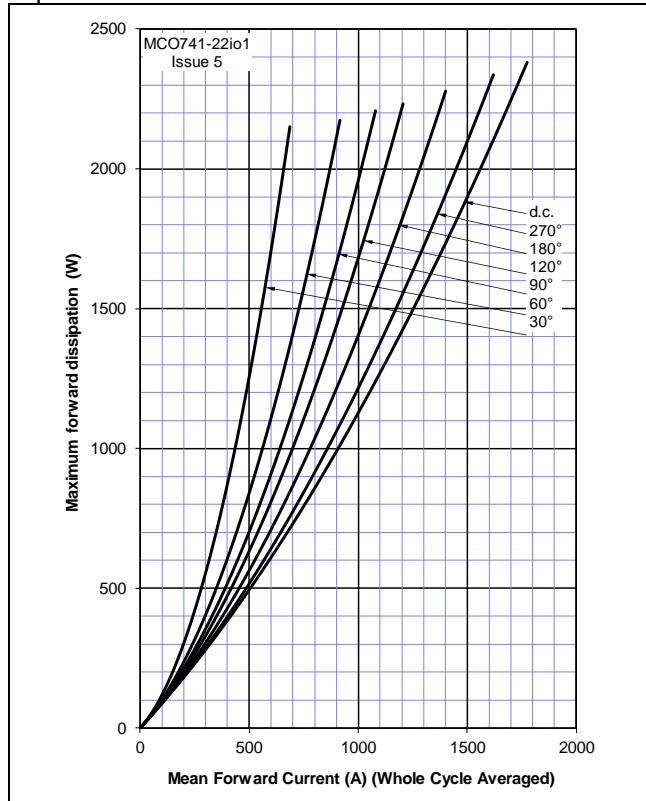


Figure 7 – On-state current vs. Heatsink temperature – Square wave

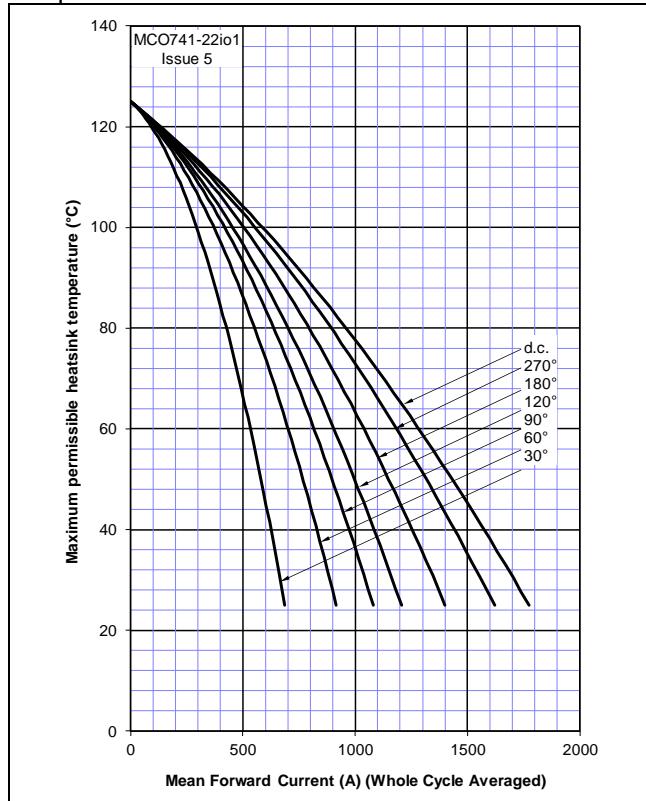


Figure 8 – Maximum surge and I^2t Ratings

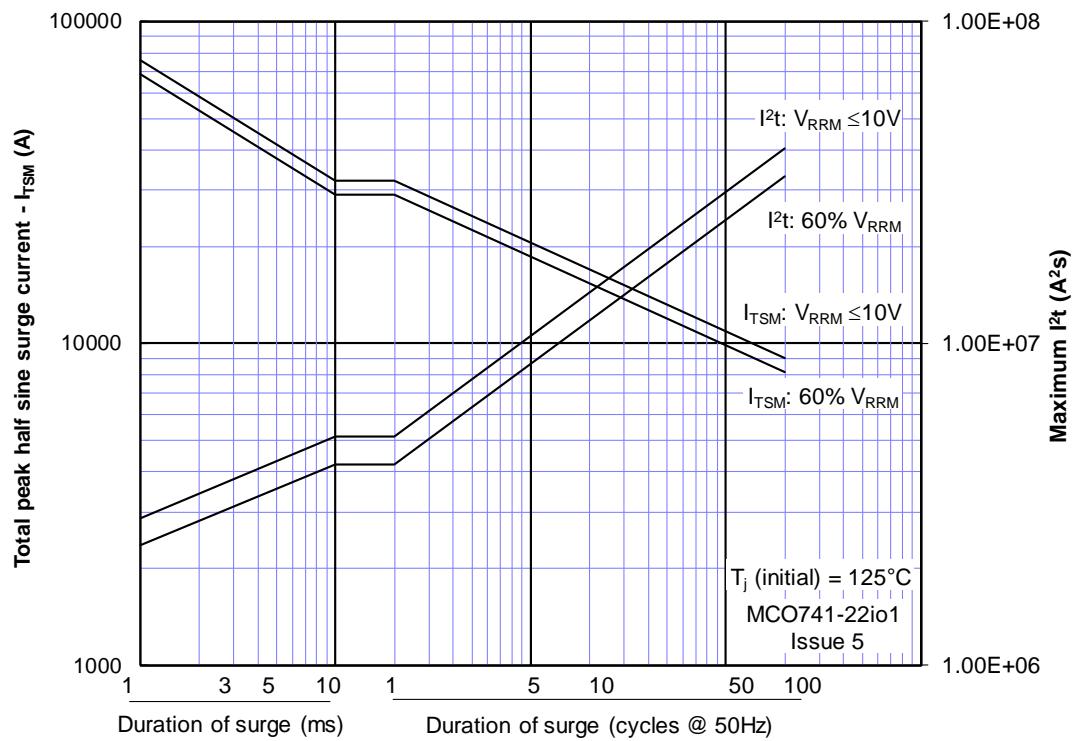
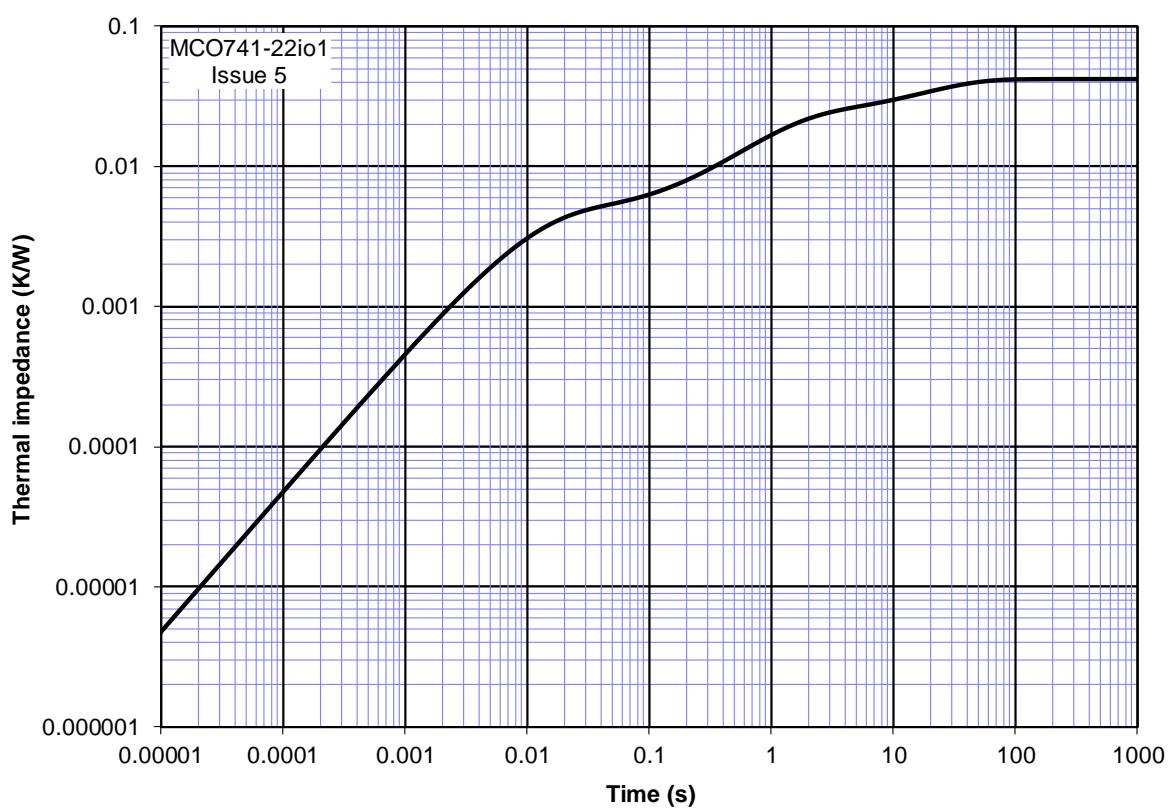


Figure 9 – Transient Thermal Impedance



Outline Drawing & Ordering Information

W73 – 150A122									
ORDERING INFORMATION (Please quote 11 digit code as below)									
M	CO	741	◆◆	io	1				
Fixed Type Code	Fixed Configuration code	Nominal Current Rating	Voltage code V _{RRM} /100 22	i = Critical dv/dt 1000 V/μs o = Typical turn-off time	Fixed Version Code				
Typical order code: MCO741-22io1, 2200V V _{DRM} , V _{RRM} thyristor module									
IXYS Semiconductor GmbH Edisonstraße 15 D-68623 Lampertheim Tel: +49 6206 503-0 Fax: +49 6206 503-627 E-mail: marcom@ixys.de									
IXYS Corporation 1590 Buckeye Drive Milpitas CA 95035-7418 Tel: +1 (408) 547 9000 Fax: +1 (408) 496 0670 E-mail: sales@ixys.net			IXYS UK Westcode Ltd Langley Park Way, Langley Park, Chippenham, Wiltshire, SN15 1GE. Tel: +44 (0)1249 444524 Fax: +44 (0)1249 659448 E-mail: sales@ixysuk.com						
www.ixysuk.com			IXYS Long Beach, Inc IXYS Long Beach, Inc 2500 Mira Mar Ave, Long Beach CA 90815 Tel: +1 (562) 296 6584 Fax: +1 (562) 296 6585 E-mail: service@ixyslongbeach.com						
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